

<b>Notice of References Cited</b>	Application/Control No. 10/555,664	Applicant(s)/Patent Under Reexamination ASSAF ET AL.	
	Examiner SUN JAE Y. LOEWE	Art Unit 1626	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**NON-PATENT DOCUMENTS**

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	U	Thatcher et al, caplus an 2005:547257
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